

Page 1 of 1 Application No. Applicant(s) PTO-1449 10/039,184 John E. Jenne et al. **Information Disclosure Citation** Filing Date **Docket Number Group Art Unit** in an Application December 21, 2001 069099.0107 2155 **U.S. PATENT DOCUMENTS** SUBCLASS **FILING DATE** DATE NAME **CLASS** PT DOCUMENT NO. A. 2/22/94 Drake et al. 370 17 7/31/92 5289460 В. 2/27/96 5805785 9/8/98 Dias et al. 395 182.02 C. 6/1/01 20020034178 3/21/02 370 386 Schmidt et al. D. 4 1/29/99 714 6438705 8/20/02 Chao et al. Ε. 392 10/13/98 10/22/02 370 6470013 Barach et al. F. 20020165962 11/7/02 Alvarez et al. 709 226 2/2/01 G. 359 118 2/28/01 20020176131 11/28/02 Walters et al. H. 709 3/11/98 316 6499064 12/24/02 Carlson et al. I. 370 401 7/11/01 20030012204 1/16/03 Czeiger et al. J. 5/14/02 20030091267 5/15/03 Alvarez et al. 385 16 ĸ. 709 220 12/5/99 6662219 12/9/03 Nishanov et al. L. 11/7/00 11/23/04 Schuster et al. 370 389 6822957 M. 20050018709 1/27/05 Barrow et al. 370 465 9/10/01 N. 20050044354 2/24/05 Hagerman 713 160 9/21/04 Ο. Gamache et al. 709 226 7/2/01 6938084 8/30/05 P. 9/25/01 6944829 9/13/05 Dando 715 798 Q. 6954463 370 401 12/11/00 10/11/05 Ma et al. **FOREIGN PATENT DOCUMENTS** TRANSLATION DATE COUNTRY **CLASS SUBCLASS** DOCUMENT NO. YES NO 2 R. S. T.

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